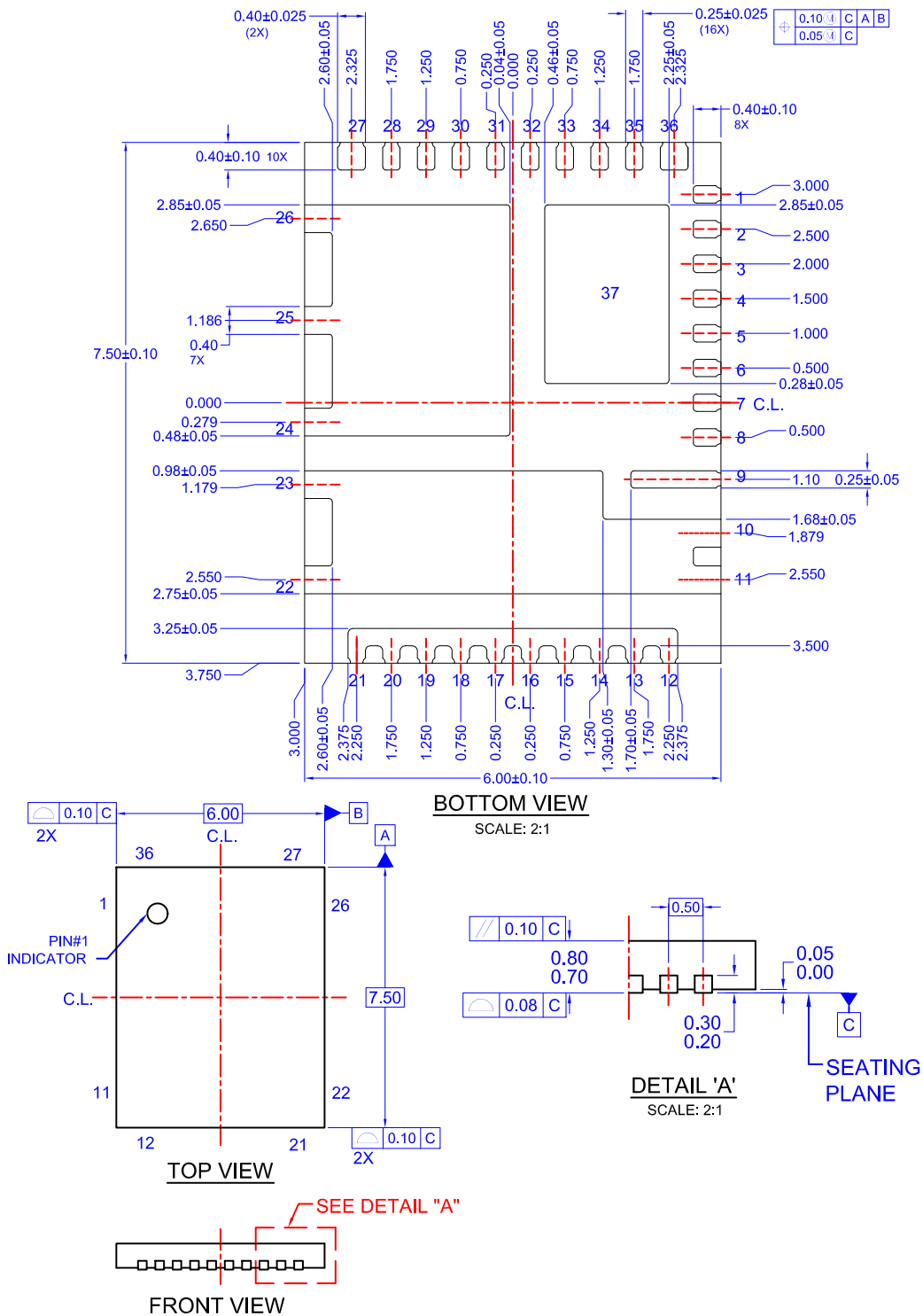


PQFN36 6X7.5, 0.5P
CASE 483BB
ISSUE O

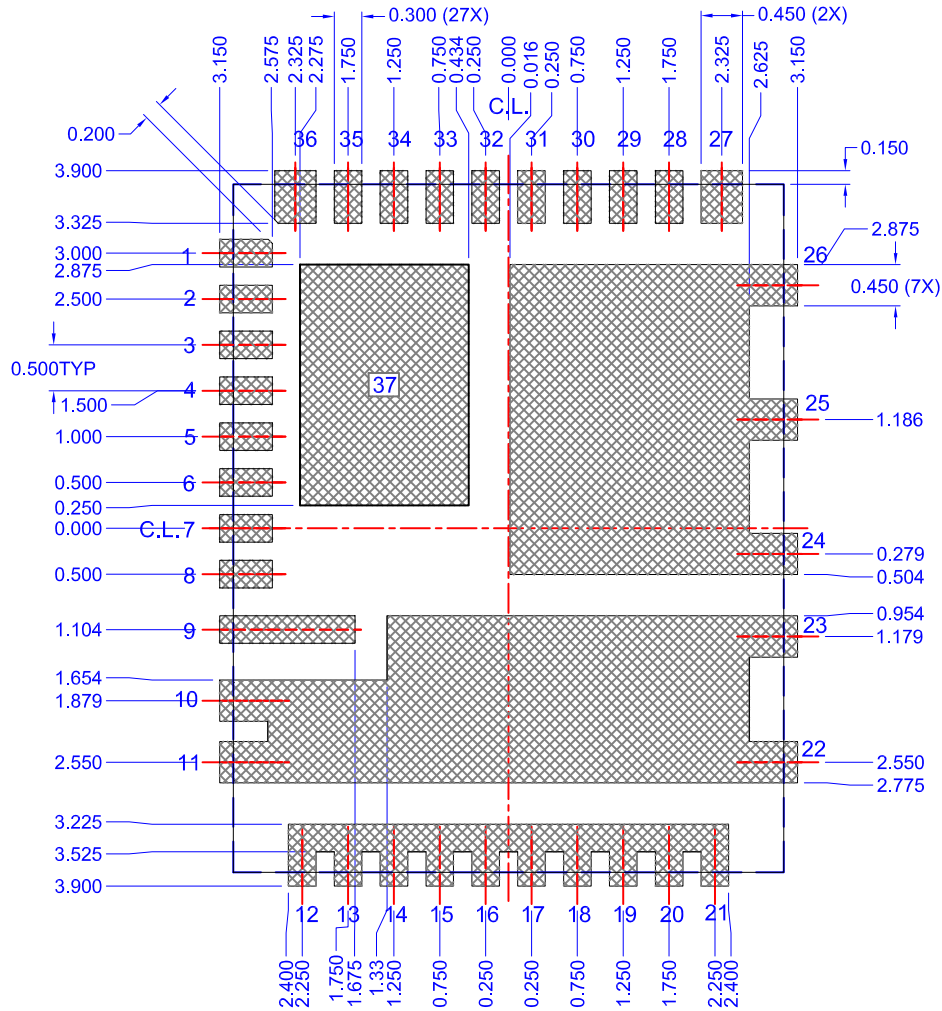
DATE 30 SEP 2016



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CASE 483BB
ISSUE O

DATE 30 SEP 2016



LAND PATTERN RECOMMENDATION

SCALE 2:1

NOTES: UNLESS OTHERWISE SPECIFIED

- A) DOES NOT FULLY CONFORM TO JEDEC MO-220, ISSUE K.01, DATED AUG 2011.
- B) ALL DIMENSIONS ARE IN MILLIMETERS.
- C) DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH. MOLD FLASH OR BURRS DOES NOT EXCEED 0.10MM.
- D) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-2009.

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